Notice of References Cited

Application/Control No.

10/081,768

Examiner

Michael Barr

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,060,121	05-2000	Hidber et al.	427/261
	В	US-			
	С	US-			
	D	US-			
	E	US-			
ı	F	US-			
	G	US-			
	Н	US-			
	1	US-			
1	j	US-			
	К	US-			
	Ļ	US-			
T	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
_	N					
	0					
	P					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	TOTAL VIEW DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
x	U	Boonekamp et al., "Adsorption of Nanometer-Sized Palladium Particles on Si(100) Surfaces", LANGMUIR, 10, American Chemical Society, 1994, ppgs. 4089-4094.				
	V					
	w					
	Х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.